

# Search Notes



Application/Control No.

10/007,899

Examiner

Tse Chen

Applicant(s)/Patent under  
Reexamination

TURNER ET AL.

Art Unit

2116

## SEARCHED

Class	Subclass	Date	Examiner

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Text search only - see search rpt printout	8/10- 8/11/05	TSE